

## **Notice of References Cited**

Application/Control No.  
10/074,944

Applicant(s)/Patent Under Reexam  
Kraine et al

Examiner  
Greg Binda

Art Unit  
3679

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### U.S. PATENT DOCUMENTS

	<b>Document Number</b> Country Code-Number-Kind Code	<b>Date</b> MM-YYYY <sup>1</sup>	<b>Name</b>	<b>Classification<sup>2</sup></b>	
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### NON-PATENT DOCUMENTS

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
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<sup>1</sup> Dates in MM-YYYY format are publication dates.

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